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First principles prediction of electronic, mechanical, transport and optical properties of the silicane/Ga₂SSe heterostructure

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In this work, we investigated the electronic structure, and mechanical, transport and optical properties of the van der Waals heterostructure formed from silicane (SiH) and Janus Ga₂SSe monolayers using first-principles prediction. The out-of-plane symmetry in the Janus Ga₂SSe monolayer leads to the formation of two different types of Ga₂SSe/SiH heterostructure, namely SGa₂Se/SiH and SeGa₂S/SiH stacking patterns. All stacking patterns of the SiH/Ga₂SSe heterostructure are thermodynamically, mechanically and energetically stable at room temperature. Furthermore, the generation of the SiH/Ga₂SSe heterostructure gives rise to a reduction in the band gap, demonstrating that the electrons move faster from the valence bands to the conduction bands. The SiH/Ga₂SSe heterostructure is a semiconductor with a direct band gap of about 0.68 or 0.95 eV, depending on the stacking pattern. The SiH/Ga₂SSe heterostructure forms type-II band alignment for all stacking patterns, indicating that the photogenerated carriers are separated effectively, thus enhancing the photocatalytic performance. Moreover, the carrier mobilities for electrons and holes of the Ga₂SSe/SiH heterostructure are higher than those of the constituent SiH and Ga₂SSe monolayers in both the x and y directions, suggesting that the performances of electronic devices based on the Ga₂SSe/SiH heterostructure would be excellent and reliable. The formation of the Ga₂SSe/SiH heterostructure also gives rise to an enhancement of the absorption coefficient in both the visible and ultraviolet regions. Our findings could give valuable guidance for the design of high-efficiency devices based on the SiH/Ga₂SSe heterostructure.

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1 Introduction

In recent years, two-dimensional (2D) materials with extraordinary properties and wide ranging applications in different fields have become promising objects of interest in the research community, from fundamental research to practical applications. To date, a plethora of 2D materials have been successfully synthesized in experiments and theoretically predicted, such as graphene,¹ h-BN,² phosphorene³ and transition metal mono(di) chalcogenides (TMCs).^{4,5} These 2D materials exhibit a lot of unusual physical and chemical properties that make them promising for energy conversion and storage devices,⁶ field-effect transistors (FETs)⁷ and photocatalytic devices.⁸ For instance, the high carrier mobility in graphene⁹ makes it a promising candidate for high-speed FETs.¹⁰ Unlike graphene, most TMCs have moderate band gaps of about 1–3 eV that make them more attractive for high-performance electronic devices.^{11,12} However, these 2D materials have some drawbacks that may hinder their applications in various fields, including electronic, optoelectronic and photocatalytic applications. For instance, the absence of a band gap in graphene hinders its

application in electronic switching devices.¹³ The mechanical instability of phosphorene in an atmospheric environment¹⁴ limits its use in flexible applications.¹⁵ Therefore, the search for novel 2D materials with unusual properties and potential applications presents many challenges for the research community.

Recently, a new type of 2D material, namely the Janus MoSSe structure has been successfully synthesized.^{16,17} The Janus MoSSe structure exhibits many unusual properties, such as Rashba spin splitting and piezoelectric polarization, that have not been found in the parent MoS₂ and MoSe₂ materials.^{18,19} After this success, many different Janus structures have been synthesized and predicted, including Pd₄X₃Y₃ (X ≠ Y = S, Se, Te),²⁰ PtSSe²¹ and MoSiGeN₄.²² More recently, Guo *et al.* predicted a new Janus structure based on the parent GaS monolayer, namely the Janus Ga₂SSe monolayer.²³ The results demonstrated that the piezoelectric coefficients of the Janus Ga₂SSe monolayer are enhanced up to 8.47 pm V⁻¹ as compared to the GaS monolayer. The Janus Ga₂SSe monolayer is predicted to be thermodynamically, dynamically and mechanically stable at room temperature. Additionally, a high intrinsic electron mobility of up to 10 cm² V s⁻¹ (ref. 24) makes the Janus Ga₂SSe monolayer a promising candidate for ultra-small sized FETs, which can be used to replace silicon-based devices.

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Silicane (SiH), a puckered honeycomb structure obtained by full hydrogenation of 2D silicene, has attracted increasing interest owing to its unique electronic characteristics and promising applications.^{25,26} The hydrogenation of 2D silicene on both edges to form the SiH material gives rise to opening of the band gap to about 3 eV,²⁵ making it suitable for high-efficiency applications.²⁷ Currently, in order to modify the properties of the SiH material, the research community mainly focuses on the combination of SiH and other 2D materials to create heterostructures.^{28,29} For instance, Han *et al.*²⁹ performed first-principles calculations to investigate the electronic and optical properties of the combination between SiH and PtSe₂ materials. They predicted that the combined SiH/PtSe₂ heterostructure has enhanced optical absorption as compared to the parent SiH and PtSe₂ materials. This enhancement suggests that the combined SiH/PtSe₂ heterostructure can be considered as a highly efficient component for photocatalytic applications. Zeng *et al.*²⁷ constructed the SiH/CeO₂ heterostructure with enhanced visible light absorption performance compared to the constituent monolayers. They also suggested that the combined SiH/CeO₂ heterostructure is a promising material for water splitting applications. Very recently, Lv *et al.* suggested that the UV absorptivity in the SiH/GaN heterostructure can reach 21.6%, which is greater than that of the constituent SiH and GaN monolayers. The enhancement in the UV absorptivity in the SiH/GaN heterostructure makes it suitable for ultraviolet optoelectronic devices.

In this work, we perform first-principles calculations to construct the combined SiH/Ga₂SSe heterostructure and investigate its electronic, mechanical and optical properties. The out-of-plane symmetry in the Janus Ga₂SSe monolayer leads to the formation of two different types of Ga₂SSe/SiH heterostructure, namely SGa₂Se/SiH and SeGa₂S/SiH stacking patterns. All stacking patterns of the SiH/Ga₂SSe heterostructure are thermodynamically, mechanically and energetically stable at room temperature. The formation of type-II band alignment in the Ga₂SSe/SiH heterostructure is also examined. The Ga₂SSe/SiH heterostructure has an excellent carrier mobility and a large absorption coefficient in both the visible and ultraviolet regions.

2 Computational methods

All calculations were performed in the framework of first-principles prediction based on density functional theory (DFT) using the Vienna *ab initio* simulation package (VASP).³⁰ The Perdew–Burke–Ernzerhof (PBE) functional³¹ in the framework of the generalized gradient approximation was selected for describing the exchange–correlation energy. The geometric optimization process was fully relaxed until the forces and energy were less than 0.001 eV Å⁻¹ and 10⁻⁵ eV, respectively. A cutoff energy of 510 eV was selected for plane-wave expansion. A Monkhorst–Pack grid with a 9 × 9 × 1 *k*-point mesh was selected for all the optimization process and electronic features calculations. A vacuum thickness of 40 Å was used to prevent the interaction between adjacent layers along the *z* direction. The weak interlayer coupling existing in most layered

heterostructures was described by the DFT-D3 Grimme method.^{32,33} Additionally, the Heyd–Scuseria–Ernzerhof (HSE06) functional³⁴ with the mixing parameter $\alpha = 0.25$ was also examined to obtain more accurate band gaps of the materials. The phonon dispersion curves were calculated and *ab initio* molecular dynamics (AIMD) simulations were carried out using a 3 × 3 × 1 supercell to check the thermodynamical stability of the materials. The AIMD simulations were carried out with the PBE functional using the NVT ensemble at room temperature of 300 K. The simulations are governed by the Nosé–Hoover thermostat over 4 ps with a time step of 1 fs. The interval for saving snapshots in the trajectories is 1 ps.

The binding energy of the heterostructure is calculated as:

$$E_b = \frac{E_H - E_{M1} - E_{M2}}{S} \quad (1)$$

Here, the total energies of the heterostructure, and the constituent Ga₂SSe and SiH monolayers are defined by E_H , E_{M1} and E_{M2} , respectively. S stands for the surface area of the considered heterostructure.

3 Results and discussion

We first investigate the atomic and electronic characteristics of the SiH and Janus Ga₂SSe monolayers. The optimized atomic structures of SiH and Janus Ga₂SSe monolayers are depicted in Fig. 1(a) and (e), respectively. The SiH monolayer shows a buckled hexagonal atomic structure, while the Janus Ga₂SSe monolayer exhibits a layered one. The calculated lattice parameters of SiH and Ga₂SSe monolayers after geometric optimization are 3.86 and 3.73 Å, respectively. The small difference between the lattice parameters of SiH and Ga₂SSe monolayers gives rise to the generation of a small lattice mismatch in their heterostructure. The band structures of these monolayers given by the PBE and HSE06 methods are depicted in Fig. 1. The SiH monolayer exhibits semiconducting behavior with an indirect band gap of 2.18/2.92 eV for the PBE/HSE method. The lowest unoccupied conduction band (LUB) is located at the K point, while the highest occupied valence band (HOB) is located at the Γ point. Both the PBE and HSE methods predict the same semiconducting behavior of the SiH monolayer. Similarly, the Janus Ga₂SSe monolayer is also a semiconductor with an indirect band gap, generated between the LUB at the Γ point and the HOB along the Γ –K path. The calculated band gap of the Janus Ga₂SSe monolayer is 1.98/2.91 eV for the PBE/HSE method. One can find that the PBE functional can provide correct descriptions of 2D materials compared to the HSE06 functional. Therefore, we further perform all the following calculations using the PBE functional because of low computational resources. Furthermore, to verify the stability of both SiH and Ga₂SSe monolayers, we present their phonon spectra, as shown in Fig. 1(d) and (h). It is clear that all the phononic frequencies of SiH and Ga₂SSe monolayers are positive, verifying their dynamical stability.

We now design the composed heterostructure, generated from Janus Ga₂SSe and SiH monolayers. Owing to the small difference in the lattice parameters between Janus Ga₂SSe and



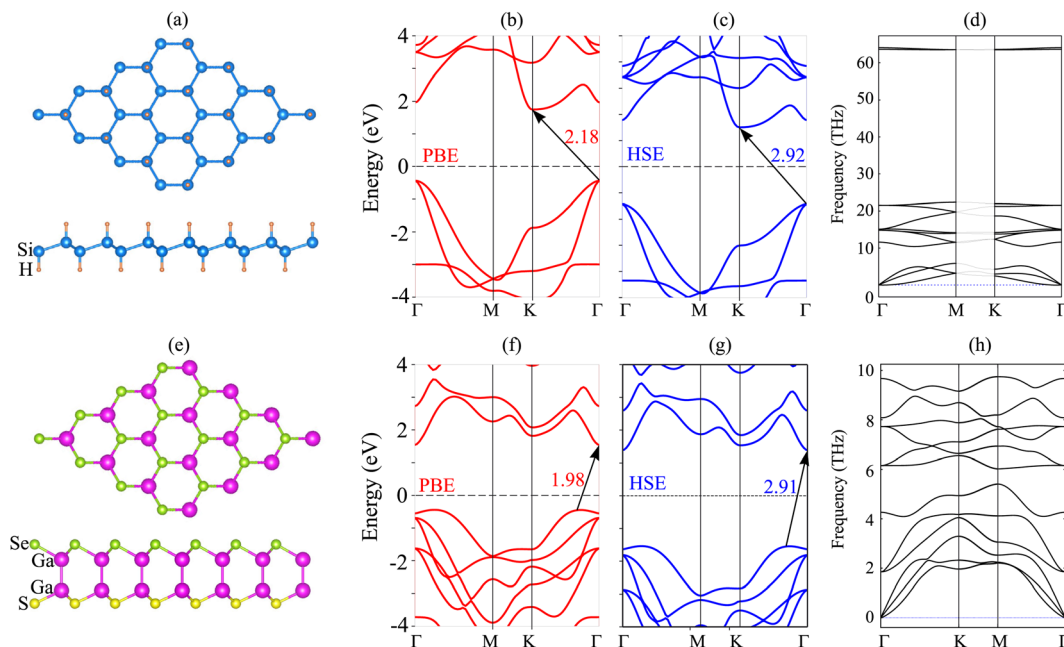


Fig. 1 (a and e) The optimized atomic structure, (b and f) PBE band structure, (c and g) HSE band structure and (d and h) phonon spectra of (a–d) SiH and (e–h) Janus Ga₂SSe monolayers.

SiH monolayers, to design the Ga₂SSe/SiH heterostructure, we use a (1 × 1) unit cell of the Ga₂SSe monolayer to match with a (1 × 1) unit cell of the SiH monolayer. The lattice parameter of the composed Ga₂SSe/SiH heterostructure is obtained to be 3.80 Å, giving rise to a small lattice mismatch of about 1.7%. This small lattice mismatch makes the heterostructure energetically favorable and suggests that it can be synthesized easily in experiments. The out-of-plane symmetry in the Janus Ga₂SSe

monolayer leads to the formation of two different types of Ga₂SSe/SiH heterostructure, namely SGa₂Se/SiH and SeGa₂S/SiH stacking patterns. Additionally, each stacking pattern of the Ga₂SSe/SiH heterostructure includes four different stacking configurations, including AA, AB, AC1 and AC2. All stacking configurations of the Ga₂SSe/SiH heterostructure are depicted in Fig. 2. After geometric optimization, we can obtain the interlayer separation *d* between the hydrogen layer in the SiH

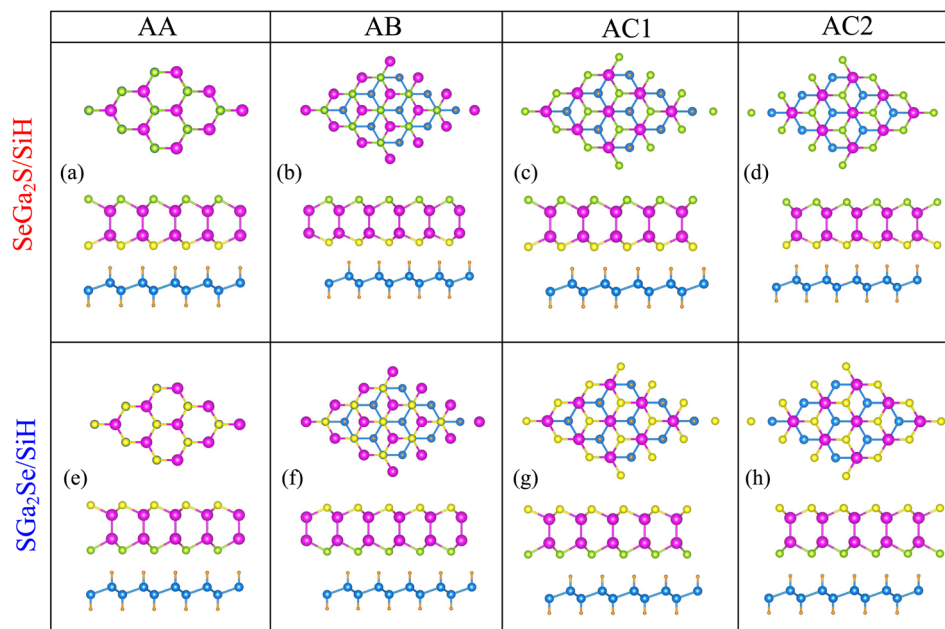


Fig. 2 Optimized atomic structures of the SeGa₂S/SiH heterostructure for different stacking patterns of (a) AA, (b) AB, (c) AC1 and (d) AC2 and optimized atomic structures of the SGa₂Se/SiH heterostructure for different stacking patterns of (e) AA, (f) AB, (g) AC1 and (h) AC2.



Table 1 Calculated interlayer separation (d , Å), binding energy (E_b , meV Å⁻²), band gap (E_g , eV) and band alignment of the Ga₂SSe/SiH heterostructure for different stacking configurations

Stacking configuration	d , Å	E_b , meV Å ⁻²	E_g , eV	Band alignment	
SeGa ₂ S/SiH	AA	2.25	-10.93	0.68	Type-II
	AB	2.24	-11.19	0.70	Type-II
	AC1	2.25	-11.23	0.68	Type-II
	AC2	2.27	-10.95	0.66	Type-II
SGa ₂ Se/SiH	AA	2.26	-11.65	0.93	Type-II
	AB	2.23	-11.86	0.97	Type-II
	AC1	2.25	-11.84	0.96	Type-II
	AC2	2.22	-11.95	0.92	Type-II

layer and the sulfur (selenide) layer in the Janus Ga₂SSe layer, which is listed in Table 1. One can find that the interlayer separation of the Ga₂SSe/SiH heterostructure for different stacking configurations is in the range from 2.22 to 2.27 Å. The AC2 stacking configuration of the SGa₂Se/SiH heterostructure is considered to be the most energetically stable because of the shortest interlayer separation and the lowest binding energy. Furthermore, one can find that the binding energy of the Ga₂SSe/SiH heterostructure is consistent with that of previously reported SiH-based heterostructures.²⁹ Furthermore, it can be seen from Table 1 that the binding energy of the SGa₂Se/SiH heterostructure is lower than that of the SeGa₂S/SiH heterostructure. The reason for such a difference is that the electronegativity of Se atoms is slightly higher than that of S atoms. This finding was also observed in previous reports.^{35–37}

The electronic band structures of the Ga₂SSe/SiH heterostructure for different stacking configurations are depicted in Fig. 3. One can find that all stacking configurations of the Ga₂SSe/SiH heterostructure are semiconductors with direct band gaps. Both the CBM and VBM of the Ga₂SSe/SiH heterostructure for all stacking configurations are located at the Γ point. Thus, the generation of the Ga₂SSe/SiH heterostructure leads to conversion from indirect semiconductors in the constituent Ga₂SSe and SiH monolayers to a direct semiconductor. Furthermore, the band gaps of the Ga₂SSe/SiH heterostructure are listed in Table 1. It is obvious that the band gaps of the SeGa₂S/SiH heterostructure are smaller than those of the SGa₂Se/SiH heterostructure. The average band gap of the SeGa₂S/SiH heterostructure is about 0.68 eV, while it is 0.95 eV for the SGa₂Se/SiH heterostructure. However, these values of the band gaps of the composed Ga₂SSe/SiH heterostructure for all stacking configurations are smaller than those of the constituent Ga₂SSe and SiH monolayers. Thus, the generation of the Ga₂SSe/SiH heterostructure gives rise to a reduction in the band gap, demonstrating that the electrons move faster from the valence bands to the conduction bands.

Interestingly, when the Ga₂SSe/SiH heterostructure is formed, it leads to the formation of type-I, type-II or type-III band alignment. According to the contributions of the Ga₂SSe and SiH layers to the band structures of the Ga₂SSe/SiH heterostructure, we find that all stacking configurations of the Ga₂SSe/SiH heterostructure form type-II band alignment. The CBM of the Ga₂SSe/SiH heterostructure for all considered stacking configurations is contributed by the Ga₂SSe layer,

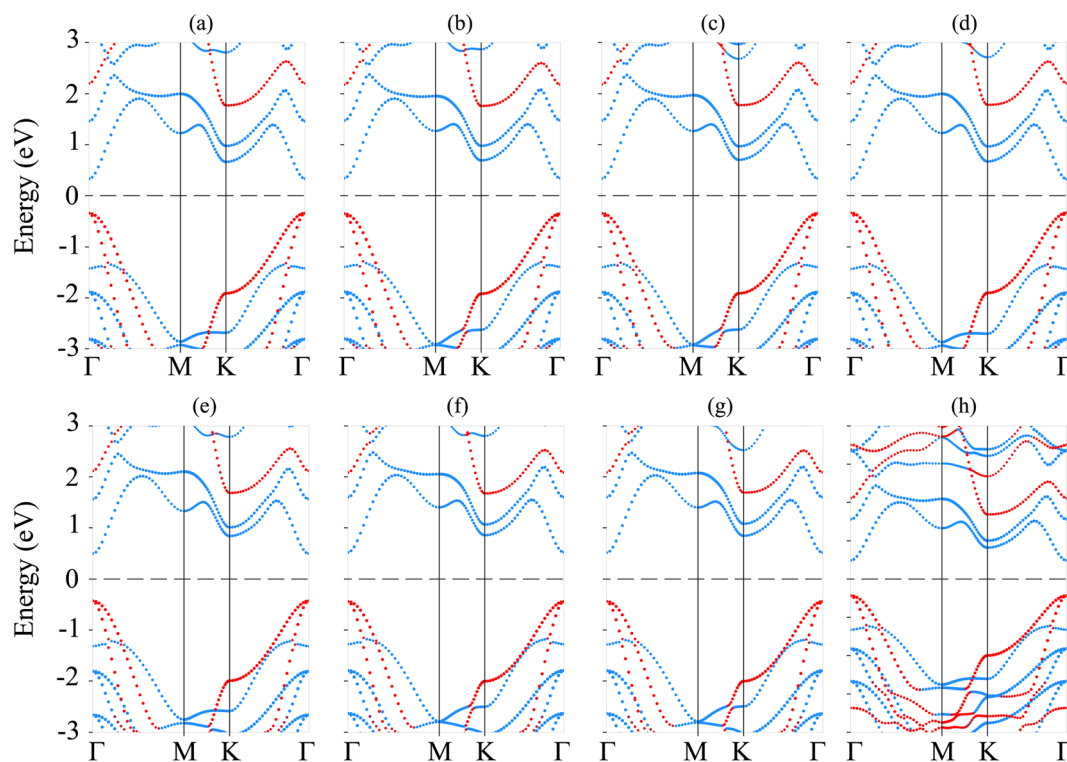


Fig. 3 Projected band structures of (a–d) SeGa₂S/SiH and (e–h) SGa₂Se/SiH heterostructures for different stacking patterns of (a and e) AA, (b and f) AB, (c and g) AC1 and (d and h) AC2. The contributions of the SiH and Ga₂SSe layers are highlighted by the red and blue lines, respectively.



while the VBM is dominated by the SiH layer. The formation of type-II band alignment in the Ga₂SSe/SiH heterostructure indicates that the photogenerated carriers are separated effectively, enhancing the photocatalytic performance.

As discussed above, the AC2 stacking configuration of the SGa₂Se/SiH heterostructure is the most energetically favorable stacking pattern; we thus focus on this pattern in all the following discussion. First, we check its dynamical, mechanical and thermodynamical stability by calculating the phonon spectrum and elastic constants, and performing *ab initio* molecular dynamics simulation, as depicted in Fig. 4. The phonon dispersion curves of the SGa₂Se/SiH heterostructure shown in Fig. 4(a) show that all frequencies are positive, suggesting that such a heterostructure is dynamically stable in the ground state. The mechanical properties are examined to evaluate the mechanical stability of the heterostructure. The elastic constants can be obtained by calculating six different finite distortions of the lattice from the stress–strain relation as follows:³⁸

$$U = \frac{V}{2} \sum_{i=1}^6 \sum_{j=1}^6 C_{ij} e_i e_j \quad (2)$$

Here, the energy of the elastic potential and the volume of the undistorted lattice cell are defined by U and V , respectively. C_{ij} is the matrix of the elastic constants, *i.e.* the second-order elastic constants in the Voigt notation and $e_i e_j$ is the matrix element of the strain vector. It should be noted that 1, 2 and 6 represent the xx , yy and xy directions of strain. The matrix of the elastic constants for 2D systems can be reduced to:

$$C = \begin{pmatrix} C_{11} & C_{12} & 0 \\ C_{12} & C_{11} & 0 \\ 0 & 0 & C_{66} = (C_{11} - C_{12})/2 \end{pmatrix}$$

Our calculations show that there are two independent elastic constants, which are calculated to be $C_{11} = 133.26 \text{ N m}^{-1}$ and $C_{12} = 30.21 \text{ N m}^{-1}$. One can find that these values of the elastic constants of the Ga₂SSe/SiH heterostructure meet the Born–Huang criteria, *i.e.* $C_{11} > 0$ and $C_{11} - C_{12} > 0$. This finding suggests that the Ga₂SSe/SiH heterostructure is mechanically stable. Additionally, the Young's modulus $Y = (C_{11}^2 - C_{12}^2)/C_{11}$ of the Ga₂SSe/SiH heterostructure is depicted in Fig. 4(b). The calculated Young's moduli for the Ga₂SSe/SiH heterostructure, and isolated Ga₂SSe and SiH monolayers are obtained to be 126.41, 69.73 and 55.17 N m^{-1} , respectively. One can find that the Young's modulus of the Ga₂SSe/SiH heterostructure is still greater than that of both the Ga₂SSe and SiH monolayers, confirming satisfactory mechanical stability. The thermal stability of the Ga₂SSe/SiH heterostructure is also evaluated by performing AIMD simulation, as shown in Fig. 4(c). It is obvious that there is a small fluctuation of the total energy and no observed structural deformation in the Ga₂SSe/SiH heterostructure, confirming that it is thermally stable at room temperature.

Moreover, when the Ga₂SSe/SiH heterostructure is formed, it leads to redistribution of charges. The charge redistribution of the Ga₂SSe/SiH heterostructure can be visualized as follows:

$$\Delta\rho = \rho_H - \rho_{M1} - \rho_{M2} \quad (3)$$

where ρ_H , ρ_{M1} and ρ_{M2} , respectively, are the charge densities of the Ga₂SSe/SiH heterostructure, and isolated Ga₂SSe and SiH monolayers. Red and cyan regions in the inset of Fig. 5(a) represent the charge depletion and accumulation, respectively. It shows that the charges are depleted on the side of the SiH layer, whereas they are accumulated on the side of the Ga₂SSe layer. This finding suggests that the charges are transferred from the SiH to the Ga₂SSe layer in the Ga₂SSe/SiH heterostructure. The charge redistribution between two layers in the heterostructure indicates that there will be a built-in electric

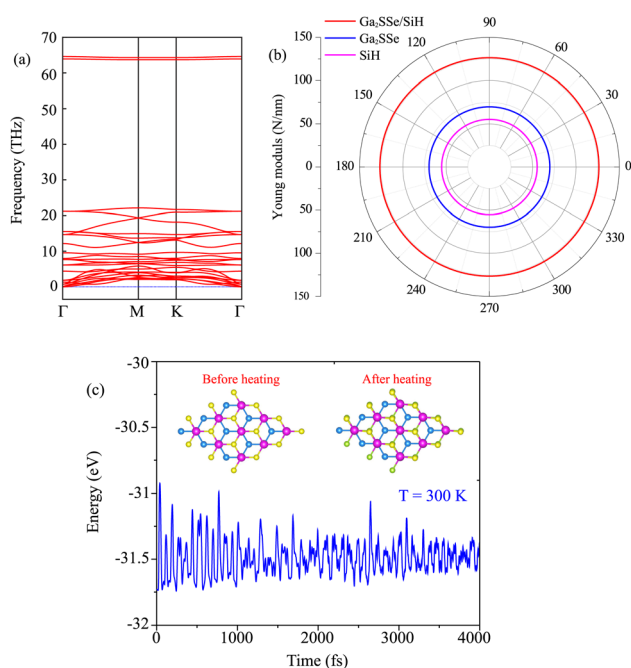


Fig. 4 (a) Phonon spectrum, (b) Young's modulus and (c) the total energy fluctuation as a function of time of the most energetically favorable stacking pattern of the heterostructure formed between the Janus Ga₂SSe and SiH monolayers. Snapshots of the Ga₂SSe/SiH heterostructure before and after heating for 4000 fs are presented in (c).

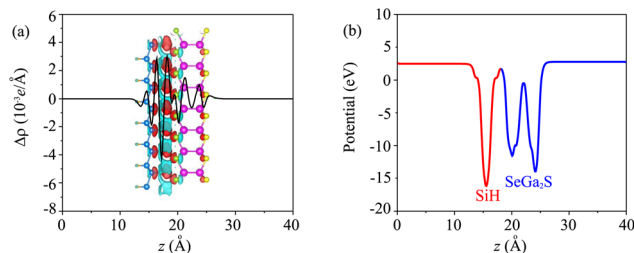


Fig. 5 (a) Planar-averaged charge density difference and (b) electrostatic potential of the most energetically favorable stacking pattern of the heterostructure formed between Janus Ga₂SSe and SiH monolayers. The inset in (a) represents the 3D charge density difference. Red and cyan regions represent the positive and negative charges, respectively.



field, pointing from the SiH to the Ga₂SSe layer in the heterostructure. Such a built-in electric field inhibits the recombination rate of photocarriers. Thus, the photocarriers, namely electrons and holes, are separated into two different layers, enhancing the photocatalysis performance. The electrostatic potential of the Ga₂SSe/SiH heterostructure is depicted in Fig. 5(b), which implies that the potential of the SiH layer is lower than that of the Ga₂SSe layer, confirming that the charges are transferred from the SiH to the Ga₂SSe layer.

Furthermore, for the use of the Ga₂SSe/SiH heterostructure as a building block in high-performance electronic devices, it is important to check the transport properties, including effective mass and carrier mobility. The carrier mobility of 2D materials can be calculated as follows:

$$\mu_i = \frac{e\hbar^3 C_{2D}^i}{k_B T m_i^* m_d E_i^2} \quad (4)$$

Here, k_B and \hbar are the Boltzmann constant and the reduced Planck constant, respectively. The effective mass for the $i = x$ or y direction is defined by m_i^* . m_d is the average of the effective masses along the x and y directions, $m_d = \sqrt{m_x^* m_y^*}$. It should be noted that the effective mass can be obtained as follows:

$$\frac{1}{m^*} = \frac{1}{\hbar^2} \times \frac{\partial^2 E(k)}{\partial k^2} \quad (5)$$

where $E(k)$ stands for the energy with the momentum k . The effective mass for electrons and holes can be obtained by quadratic fitting of the band edge energy of the CBM and VBM, respectively. E and C_{2D} represent the deformation potential constant (DP) and the elastic modulus, respectively, which can be obtained as follows:

$$C_{2D} = \frac{1}{S} \frac{\partial^2 E}{\partial \epsilon^2} \quad (6)$$

and

$$E = \frac{\Delta E_{\text{edge}}}{\epsilon} \quad (7)$$

Here, E and S represent the total energy and surface area of the material, respectively. ΔE_{edge} is the change in the band edge of the material under small strain ϵ along the x or y direction. The calculated elastic moduli and the DP constants of the isolated SiH and Ga₂SSe monolayers and the Ga₂SSe/SiH heterostructure

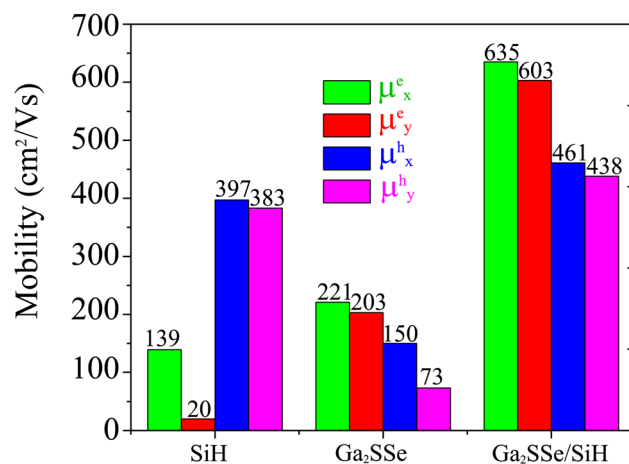


Fig. 6 Carrier mobility for electrons and holes of SiH, Ga₂SSe and the Ga₂SSe/SiH heterostructure in the x and y directions.

are listed in Table 2. One can find that the elastic modulus of the Ga₂SSe/SiH heterostructure is greater than that of the constituent monolayers. More interestingly, the carrier mobilities for electrons and holes of the Ga₂SSe/SiH heterostructure are higher than those of the constituent SiH and Ga₂SSe monolayers in both the x and y directions, as shown in Fig. 6. The calculated carrier mobilities for electrons and holes in the x direction are 635 and 461 cm² V⁻¹ s⁻¹, respectively. Whereas, they are 603 and 438 cm² V⁻¹ s⁻¹ in the y direction, respectively. The electron carrier mobility of the Ga₂SSe/SiH heterostructure is greater than its hole carrier mobility. In addition, one can find from Table 1 that the differences in the binding energies of the Ga₂SSe/SiH heterostructure for different stacking patterns are very small. Such a finding indicates that all these patterns are energetically feasible. Therefore, the carrier mobility of the AC1 stacking configuration of the SeGa₂S/SiH heterostructure is also calculated for comparison. We find that both the electron and hole carrier mobilities of the SeGa₂S/SiH heterostructure are slightly smaller than those in the SGa₂Se/SiH heterostructure. Interestingly, our findings imply that these values of carrier mobility are comparable to those in other 2D-based heterostructures,^{39,40} suggesting that the performances of electronic devices based on the Ga₂SSe/SiH heterostructure would be excellent and reliable.

Table 2 Calculated elastic modulus (C_{2D} , N m⁻¹), deformation potential constant (E_d , eV), effective mass (m^*/m_0) and carrier mobility (μ , cm² V⁻¹ s⁻¹) along the x and y directions for electrons (e) and holes (h)

Materials	Carriers	C_{2D}^x	C_{2D}^y	E_d^x	E_d^y	m_x^*	m_y^*	μ_x	μ_y
SiH	Electrons	72.54	68.99	3.728	-9.636	1.72	0.126	139	20
	Holes	72.54	68.99	-3.248	-3.224	-0.62	-0.569	397	383
Ga ₂ SSe	Electrons	90.13	90.13	-10.792	-10.792	0.267	0.291	221	203
	Holes	90.13	90.13	-2.226	-2.226	-1.34	-2.77	150	73
SGa ₂ Se/SiH	Electrons	176.88	167.84	-9.856	-9.856	0.25	0.138	635	603
	Holes	176.88	167.84	-5.324	-5.324	0.529	0.559	461	438
SeGa ₂ S/SiH	Electrons	171.8	171.9	-9.885	-9.91	0.269	0.291	497	457
	Holes	171.8	171.9	-5.28	-5.285	-0.586	-0.535	400	437



Furthermore, in view of the practical applications, it is necessary to investigate the optical properties of the heterostructure. Thus, we further calculate the optical absorption coefficient of the Ga₂SSe/SiH heterostructure as follows:

$$\alpha(\omega) = \sqrt{2}\omega \left[\frac{\sqrt{\varepsilon_1(\omega)^2 + \varepsilon_2(\omega)^2} - \varepsilon_1(\omega)}{2} \right]^{\frac{1}{2}} \quad (8)$$

Here, ε_1 and ε_2 are the real and imaginary parts of the dielectric functions, respectively. ω stands for the photon frequency. The absorption coefficients of the SiH and Ga₂SSe monolayers and the Ga₂SSe/SiH heterostructure are depicted in Fig. 7. One can find that the absorption coefficient of the Ga₂SSe/SiH heterostructure is enhanced in both the visible and ultraviolet regions as compared to the constituent SiH and Ga₂SSe monolayers. The absorption intensity of the Ga₂SSe/SiH heterostructure in the visible region is as high as $5 \times 10^4 \text{ cm}^{-1}$. Whereas, the optical absorption of the Ga₂SSe/SiH heterostructure splits into three peaks in the ultraviolet region. The maximum absorption intensity of the Ga₂SSe/SiH heterostructure in the ultraviolet region reaches $28 \times 10^4 \text{ cm}^{-1}$. Therefore, the formation of the Ga₂SSe/SiH heterostructure gives rise to an enhancement of the absorption coefficient. Furthermore, the optical absorption of the Ga₂SSe/SiH heterostructure compared to the constituent monolayers in the visible light is depicted in the inset of Fig. 7. One can find that the optical absorption of the Ga₂SSe/SiH heterostructure is two times greater than that of the constituent SiH and Ga₂SSe monolayers. This enhancement is related to the change in the band gap of such a heterostructure. Additionally, because of the reduction in the band gap of the Ga₂SSe/SiH heterostructure compared to the constituent monolayers, the Ga₂SSe/SiH heterostructure shows a good ability to absorb light in both the visible and ultraviolet regions.

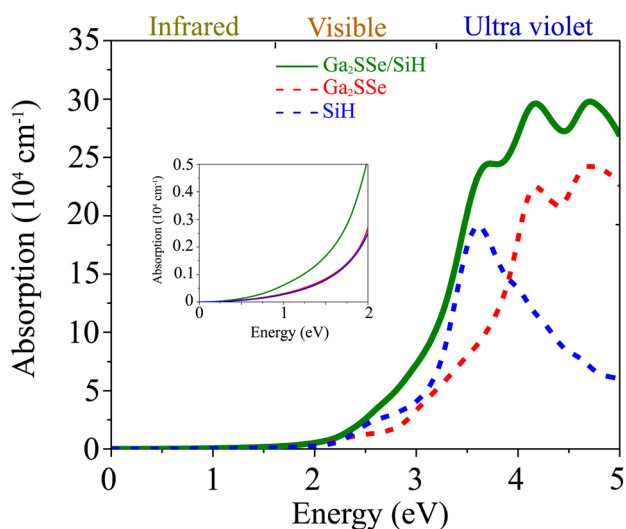


Fig. 7 Calculated absorption coefficients of SiH and Ga₂SSe monolayers and the Ga₂SSe/SiH heterostructure. The inset presents the absorption coefficients of the heterostructure and the constituent monolayers in the energy range from 0 to 2 eV.

4 Conclusions

In conclusion, we have constructed the SiH/Ga₂SSe heterostructure with different stacking patterns using first-principles prediction. The electronic, mechanical, transport and optical properties of the most energetically favorable stacking pattern are investigated to evaluate its potential in high-efficiency applications. The SiH/Ga₂SSe heterostructure is thermodynamically, mechanically and energetically stable at room temperature. The band gaps of the SiH/Ga₂SSe heterostructure are smaller than those of the constituent SiH and Ga₂SSe monolayers, suggesting that the optical absorption of such a heterostructure can be improved. The SiH/Ga₂SSe heterostructure is a semiconductor with a direct band gap of about 0.68 or 0.95 eV, depending on the stacking pattern. The SiH/Ga₂SSe heterostructure forms type-II band alignment for all stacking patterns, indicating that the photogenerated carriers are separated effectively, thus enhancing the photocatalytic performance. Moreover, the carrier mobilities for electrons and holes of the Ga₂SSe/SiH heterostructure are higher than those of the constituent SiH and Ga₂SSe monolayers in both the x and y directions, suggesting that the performances of electronic devices based on the Ga₂SSe/SiH heterostructure would be excellent and reliable. The formation of the Ga₂SSe/SiH heterostructure also gives rise to an enhancement of the absorption coefficient in both the visible and ultraviolet regions. Our findings could give valuable guidance for the design of high-efficiency devices based on the SiH/Ga₂SSe heterostructure.

Conflicts of interest

There are no conflicts to declare.

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